3	Search	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,049	OKANO ET AL.	
Examiner	Art Unit	
Randall Chin	1744	•

SEARCHED				
Subclass	Date	Examiner		
256.5	¥			
258.51	V	V		
425 ·	10/13/2008	RC		
SRCH	4/23/07	re		
SICH	7/3/67	re		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
PG-PUB	TERT		1	
SReH-				
SREH 1	STURY	W	V	
PRIN	TUUT	7/31/07	Re	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT	V	1
Inventor name search	10/13/2008	RC
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